Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10633617	SHIN ET AL.
Examiner	Art Unit
Nhon T Dien	2621

SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES				
Search Notes	Date	Examiner		
East search	6/8/2008	ND		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

U.S. Patent and Trademark Office Part of Paper No.: 20080608